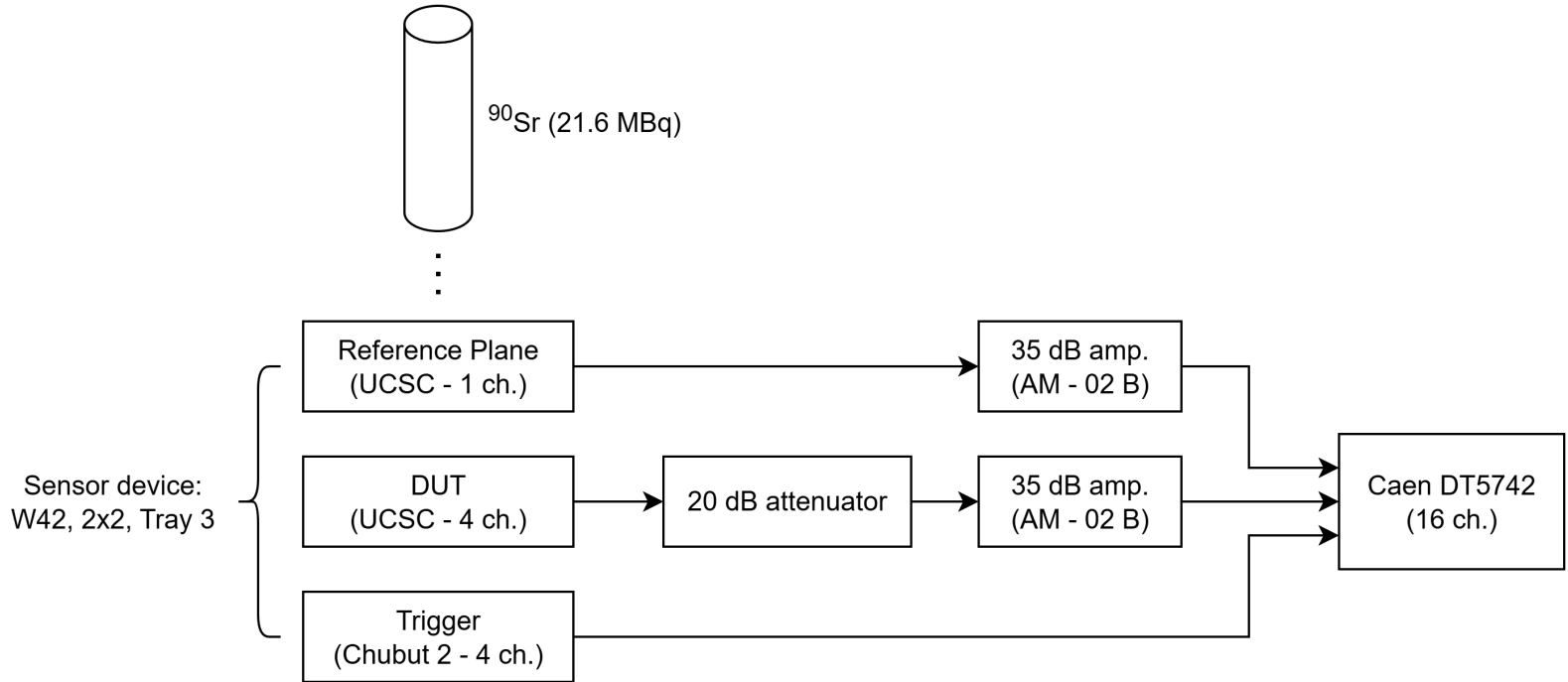
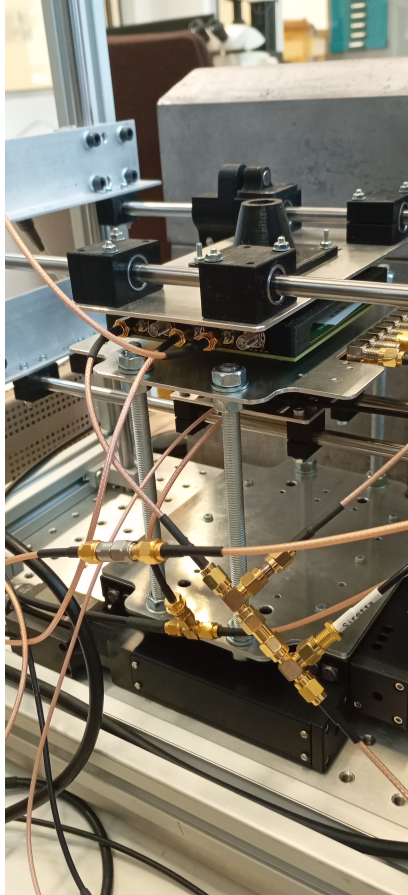


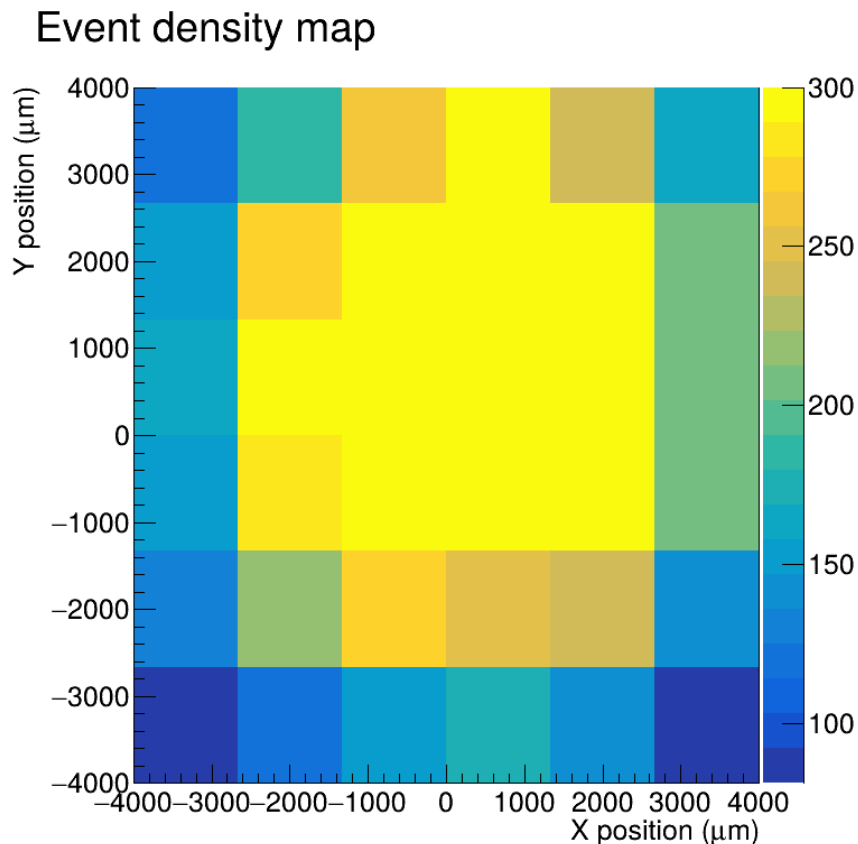
Measurement setup



DUT alignment

XY scan

- Aproximate manual alignment (set zero)
- 6x6 grid (-4 to 4 mm in both directions), acquire up to 300 events or timeout at 60 s
- Plot event density (number of hits per scan step)



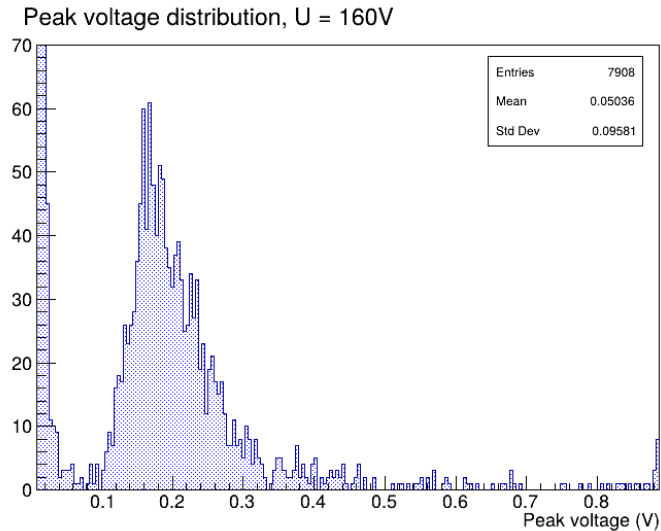
Alignment

From acquired XY data find which position has most events with both reference and DUT signal present.

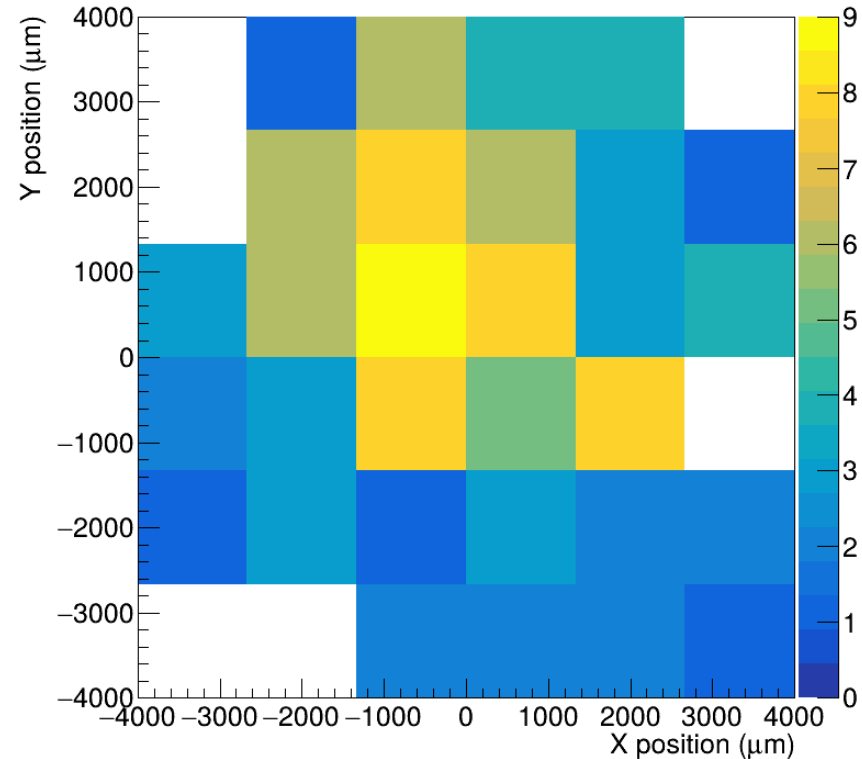
Threshold based filtering:

$\text{Peak}(\text{CH1}) > 0.1 \text{ V}$ AND $\text{Peak}(\text{CH2}) > 0.1 \text{ V}$

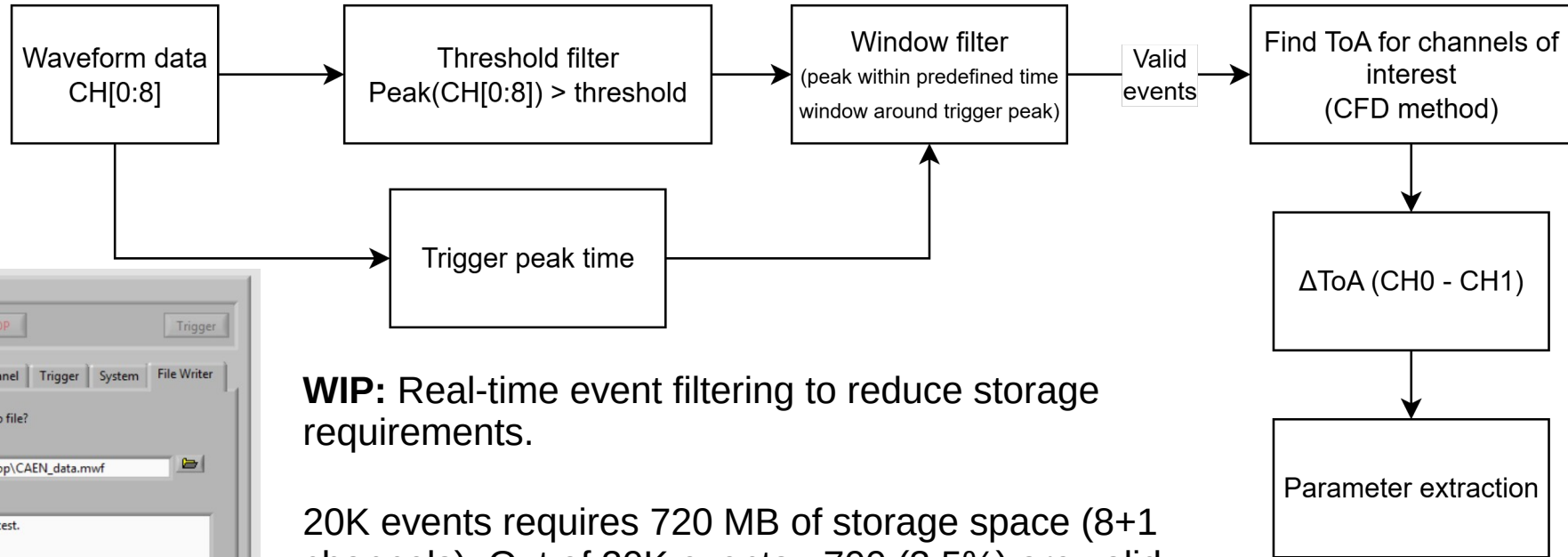
Threshold value based on peak voltage distribution.



Alignment map

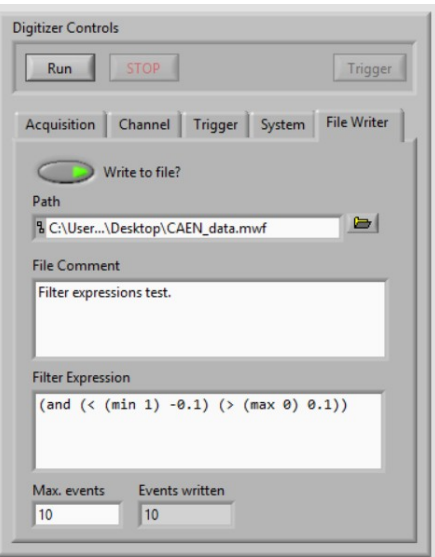


Timing data processing



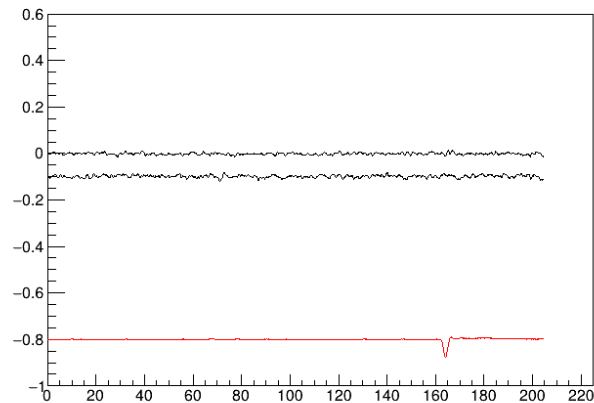
WIP: Real-time event filtering to reduce storage requirements.

20K events requires 720 MB of storage space (8+1 channels). Out of 20K events ~700 (3.5%) are valid – signal above threshold on both planes and located within trigger time window.

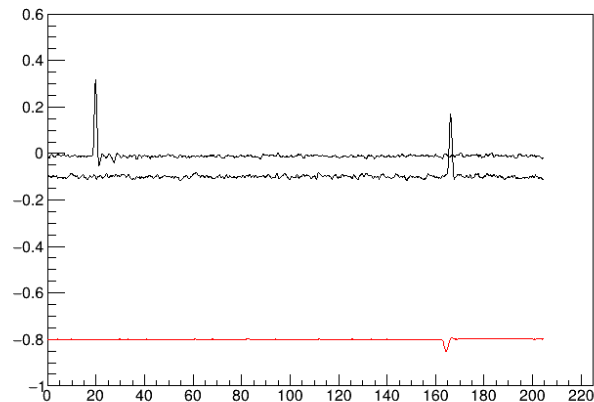


Event filter

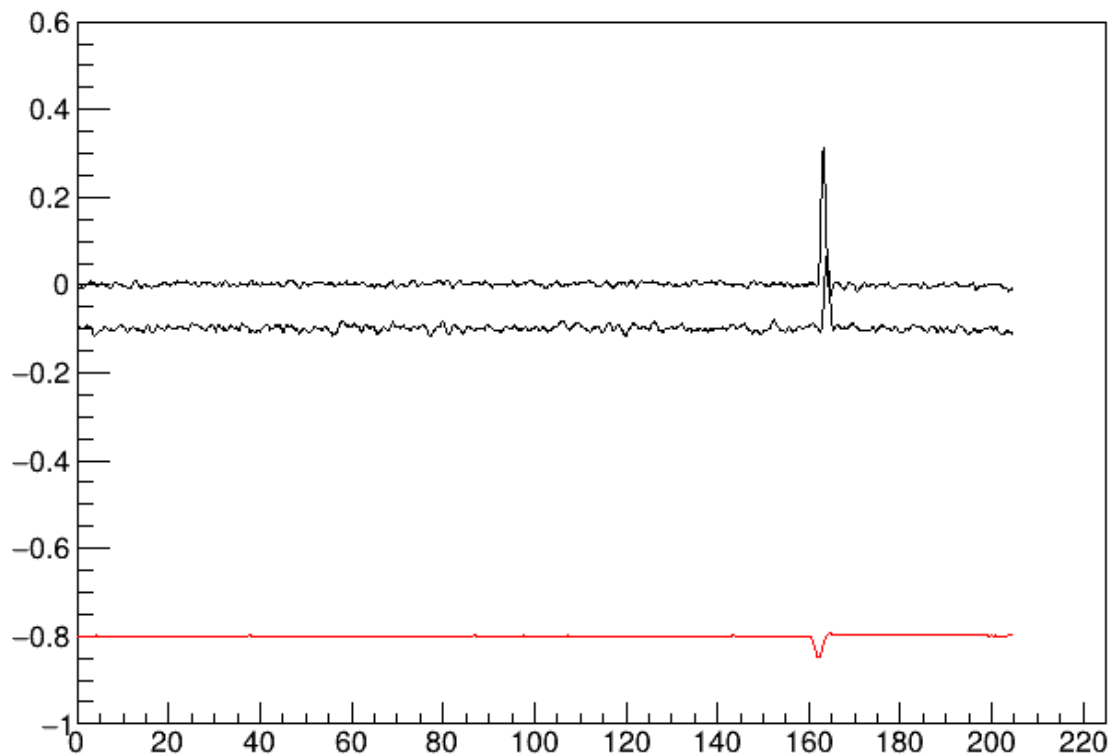
Empty event



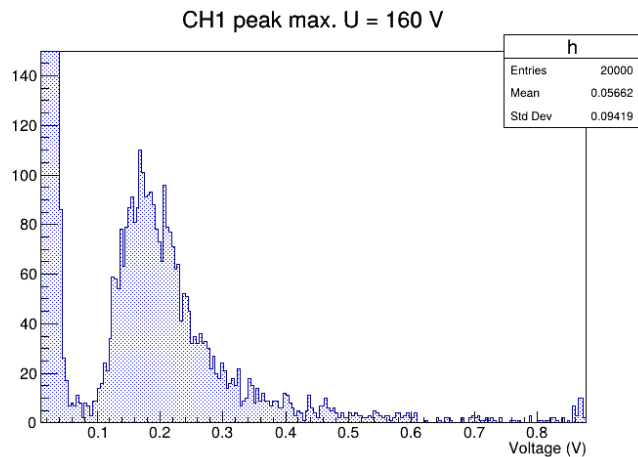
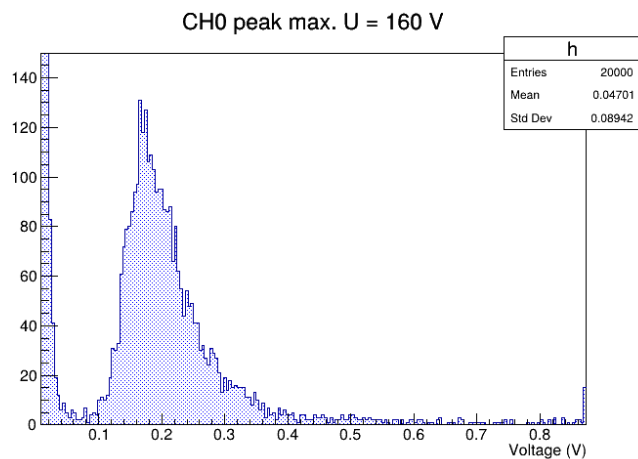
Invalid event - window



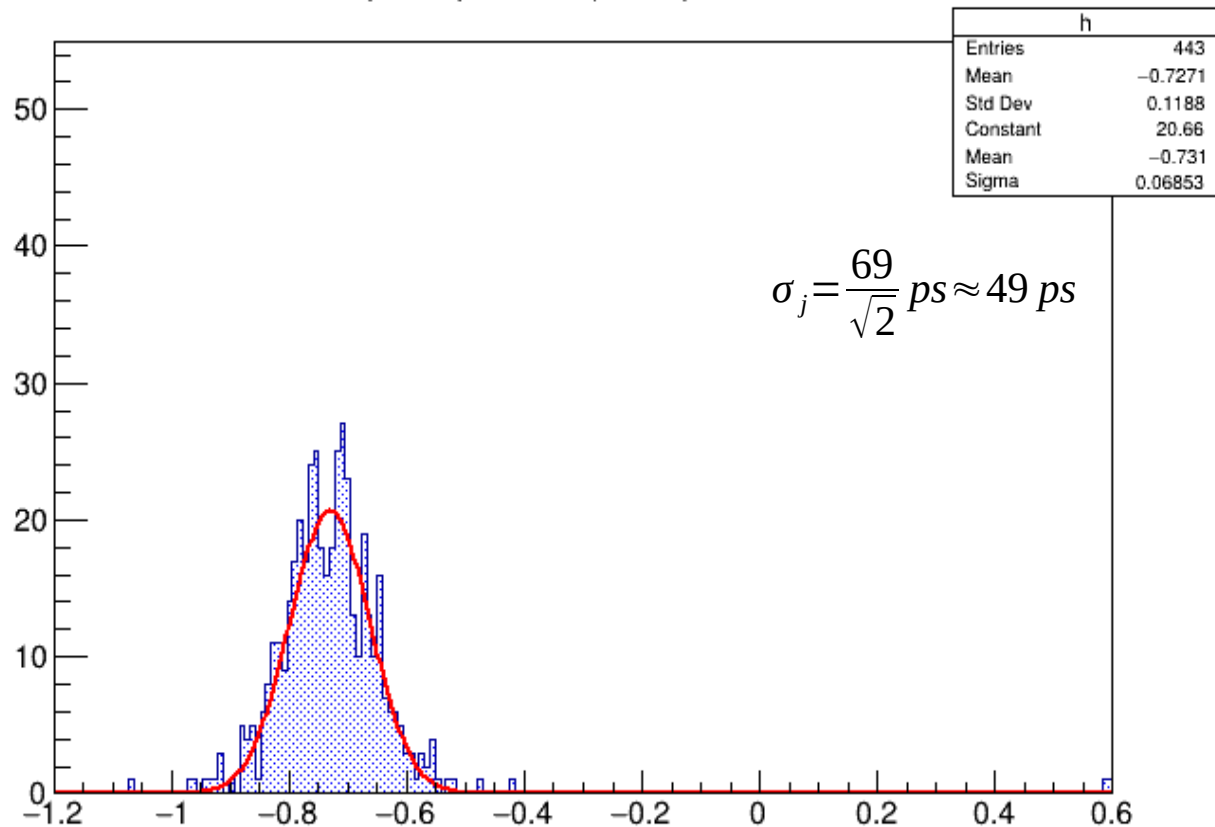
Valid event



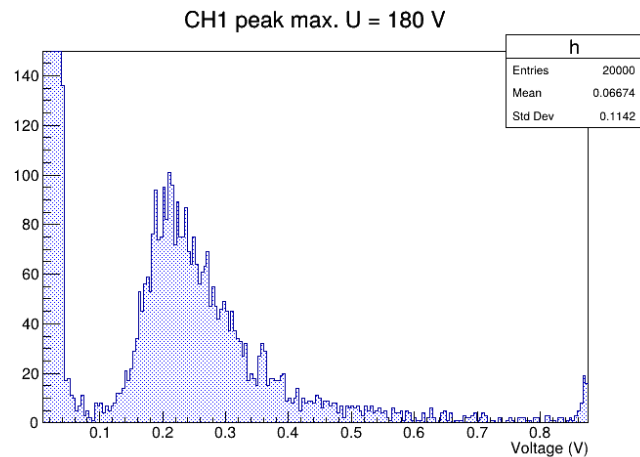
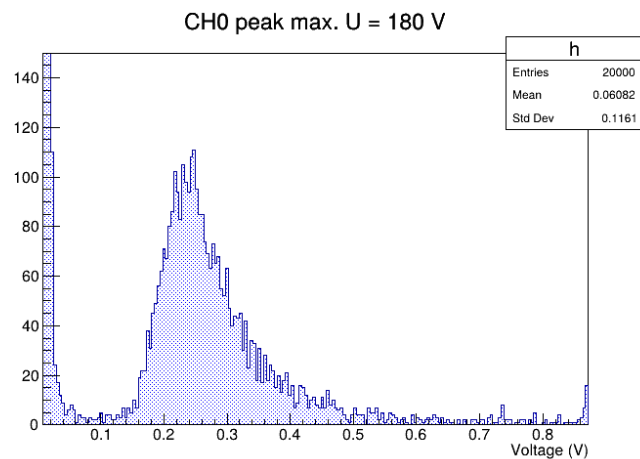
Run 1



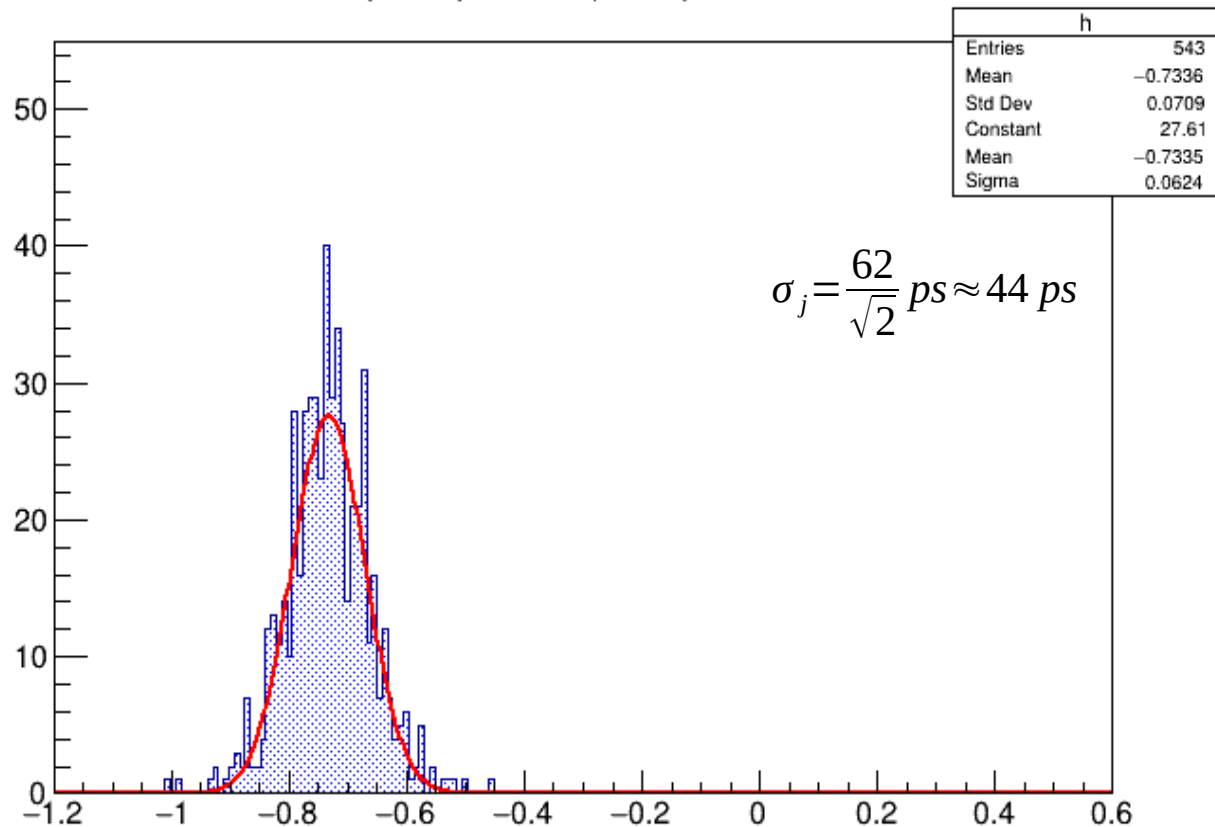
ToA(CH0) - ToA(CH1), U=160 V



Run 2

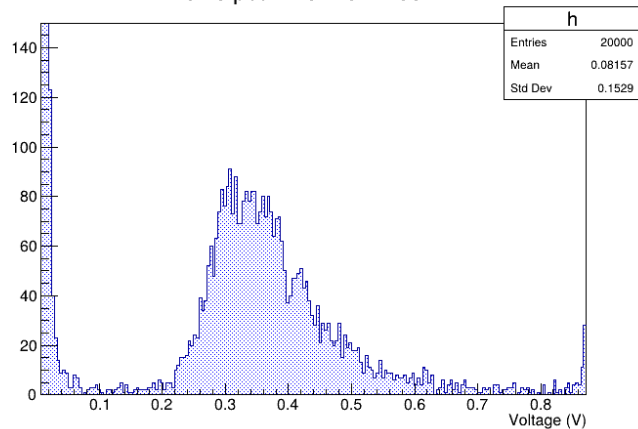


ToA(CH0) - ToA(CH1), U=180 V

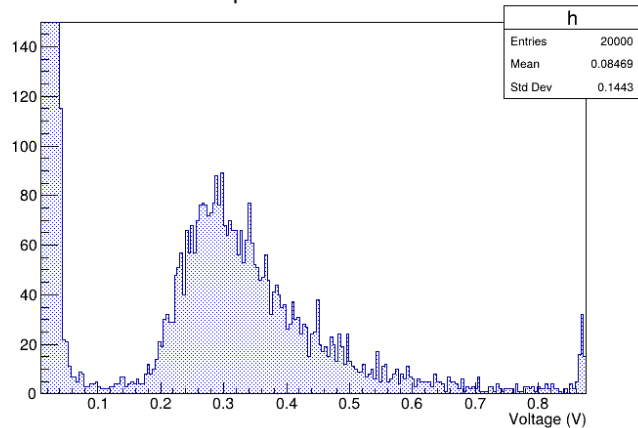


Run 3

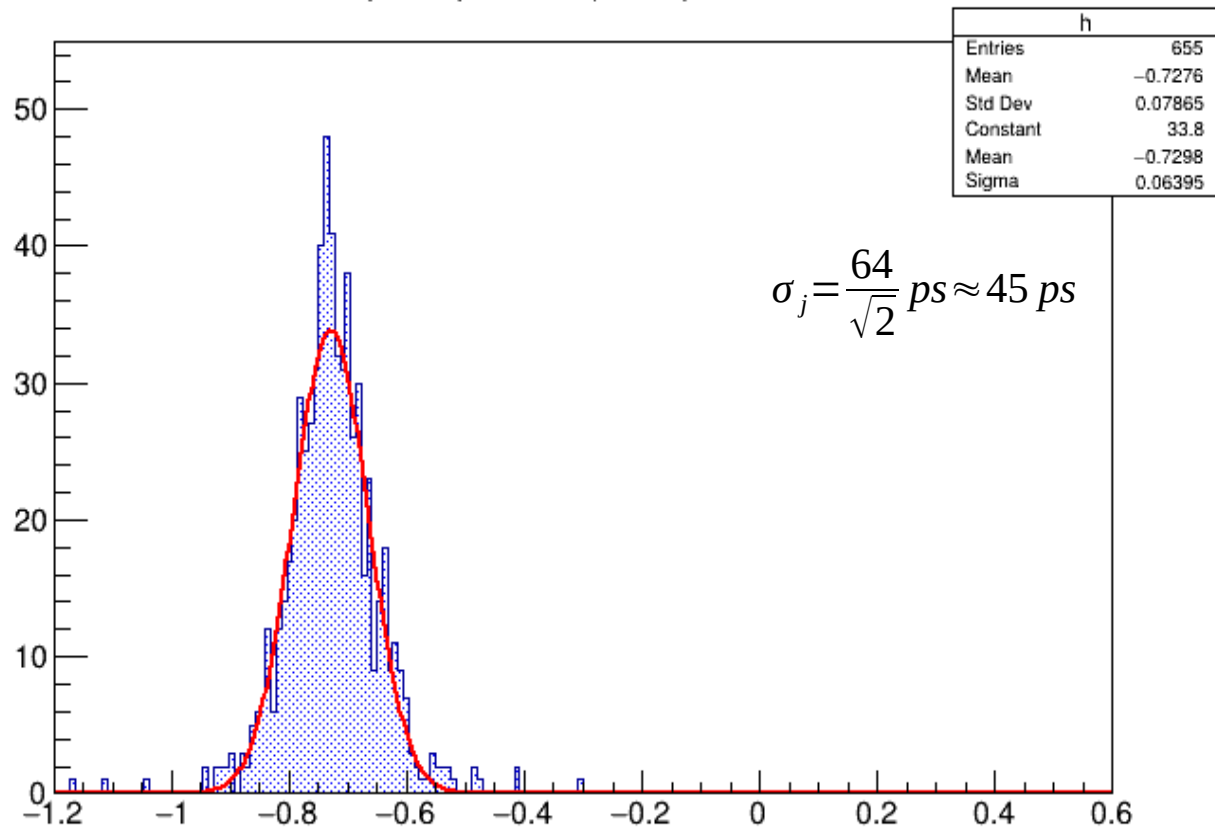
CH0 peak max. U = 200 V



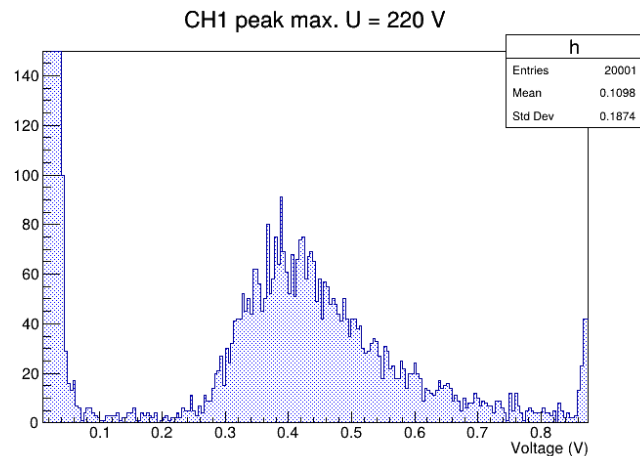
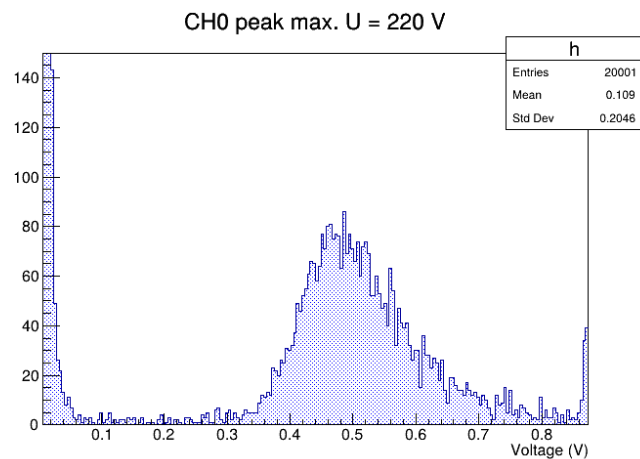
CH1 peak max. U = 200 V



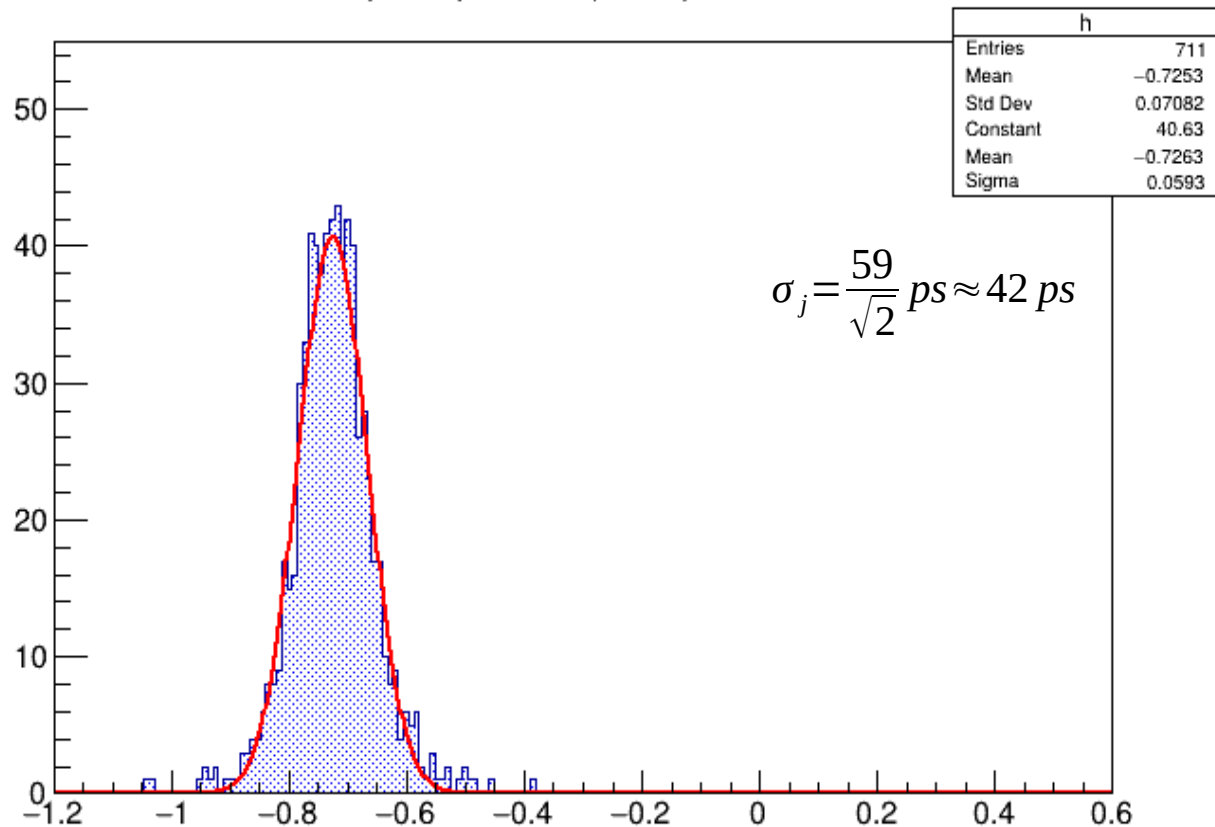
ToA(CH0) - ToA(CH1), U=200 V



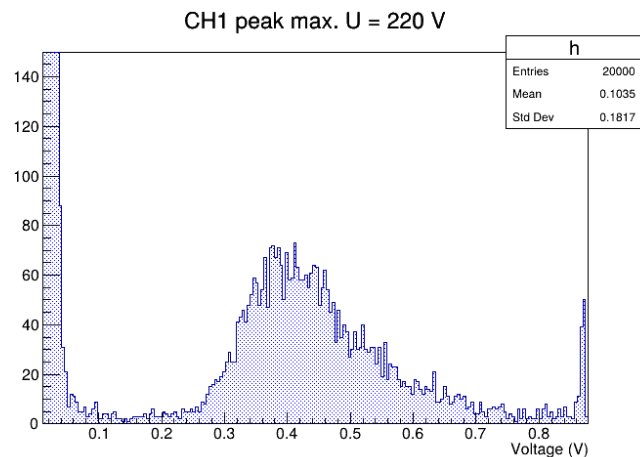
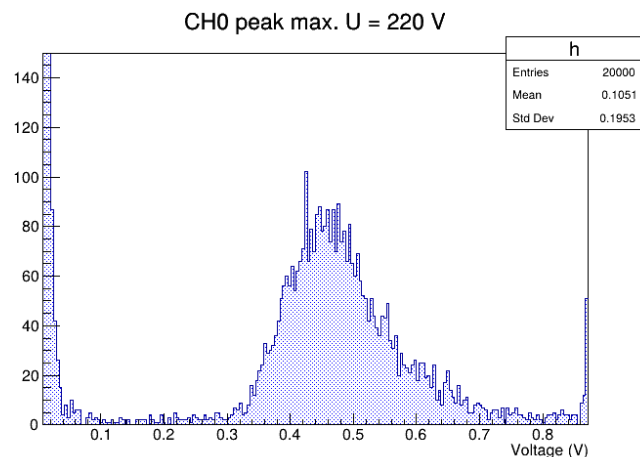
Run 4



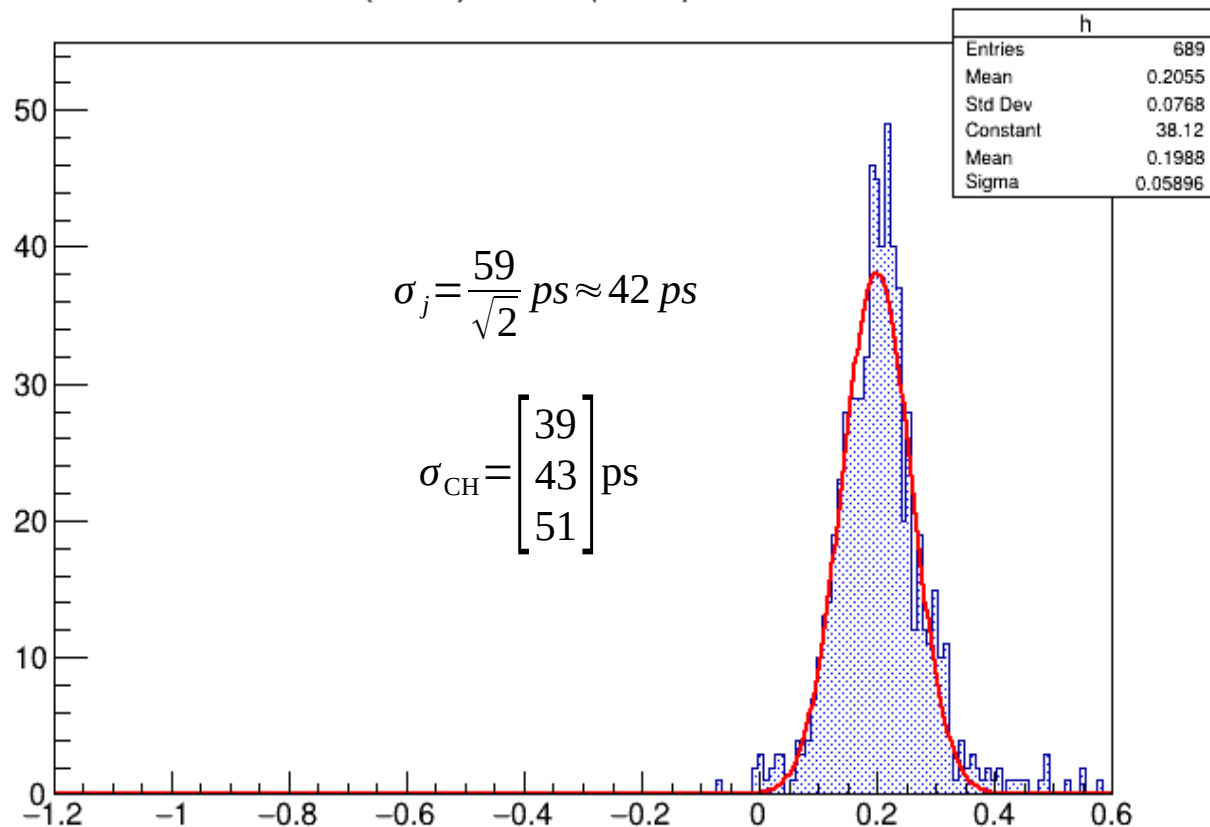
ToA(CH0) - ToA(CH1), U=220 V



Run 5, ~0.5 ns added delay to CH0



ToA(CH0) - ToA(CH1), U=220 V



Run 6 (all Chubut boards)

